Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10751436	LEE ET AL.

Examiner Art Unit

CongVan Tran 2617

SEARCHED

Class	Subclass	Date	Examiner
370	401, 328, 351	3/12/08	СТ
455	433	3/12/08	CT
370	352-356	10/10/08	CT

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH		
Subclass	Date	Examine

	/CongVan Tran/ Primary Examiner.Art Unit 2617
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